

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**OPC Unified Architecture –  
Part 8: Data Access**

**Architecture unifiée OPC –  
Partie 8: Accès aux données**





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IEC Central Office  
3, rue de Varembé  
CH-1211 Geneva 20  
Switzerland

Tel.: +41 22 919 02 11  
Fax: +41 22 919 03 00  
[info@iec.ch](mailto:info@iec.ch)  
[www.iec.ch](http://www.iec.ch)

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International Standard IEC 62541-8 has been prepared by subcommittee 65E: Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-process measurement, control and automation.

This second edition cancels and replaces the first edition published in 2011. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Clarified that deadband has to be between 0.0 and 100.0. Violations result in error Bad\_DeadbandFilterInvalid (6.2)
- b) Added VariableTypes handling ArrayItems and DataTypes supporting this, including complex number types. These data types are required for complex analyzer devices but seem useful for other domains as well.

The text of this standard is based on the following documents:

CDV	Report on voting
65E/381/CDV	65E/407/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62541 series, published under the general title *OPC Unified Architecture*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

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## OPC UNIFIED ARCHITECTURE –

### Part 8: Data Access

#### 1 Scope

This part of IEC 62451 is part of the overall OPC Unified Architecture (OPC UA) standard series and defines the information model associated with Data Access (DA). It particularly includes additional *VariableTypes* and complementary descriptions of the *NodeClasses* and *Attributes* needed for Data Access, additional *Properties*, and other information and behaviour.

The complete address space model, including all *NodeClasses* and *Attributes* is specified in IEC 62541-3. The services to detect and access data are specified in IEC 62541-4.

#### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC TR 62541-1, *OPC Unified Architecture - Part 1: Overview and Concepts*

IEC 62541-3, *OPC unified architecture - Part 3: Address Space Model*

IEC 62541-4, *OPC unified architecture - Part 4: Services*

IEC 62541-5, *OPC unified architecture - Part 5: Information Model*

UN/CEFACT: **UNECE Recommendation N° 20**, *Codes for Units of Measure Used in International Trade*, available at [http://www.unece.org/cefact/recommendations/rec\\_index.htm](http://www.unece.org/cefact/recommendations/rec_index.htm)

#### 3 Terms, definitions and abbreviations

##### 3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC TR 62541-1, IEC 62541-3, and IEC 62541-4 as well as the following apply.

###### 3.1.1

###### DataItem

link to arbitrary, live automation data, that is, data that represents currently valid information

Note 1 to entry: Examples of such data are

- device data (such as temperature sensors),
- calculated data,
- status information (open/closed, moving),
- dynamically-changing system data (such as stock quotes),
- diagnostic data.